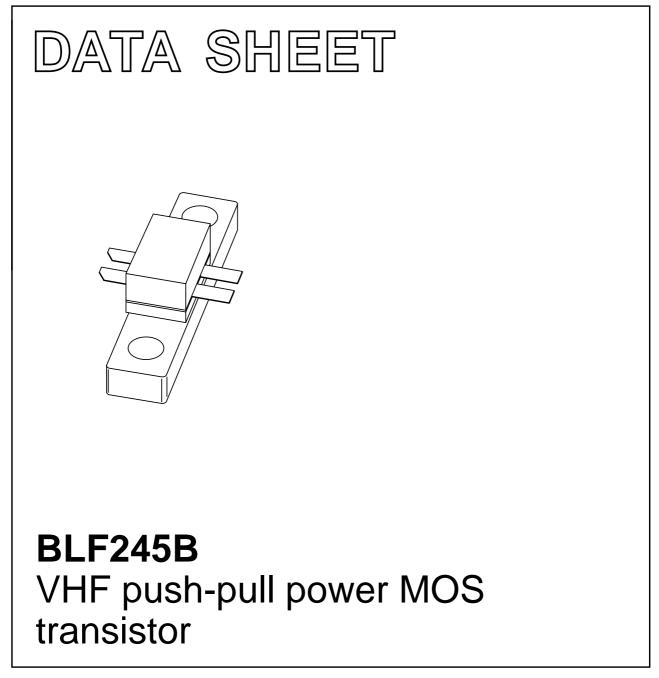
# DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 2000 Oct 17 2003 Aug 04



# BLF245B

## FEATURES

- High power gain
- · Easy power control
- Good thermal stability
- Gold metallization ensures excellent reliability.

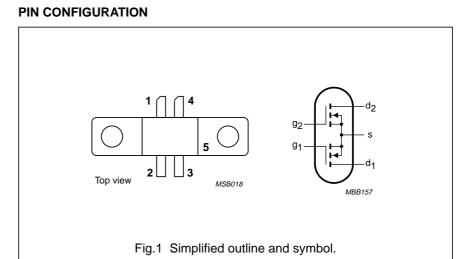
## DESCRIPTION

Dual push-pull silicon N-channel enhancement mode vertical D-MOS transistor designed for large signal amplifier applications in the VHF frequency range.

The transistor is encapsulated in a 4-lead, SOT279A balanced flange package, with a ceramic cap. The mounting flange provides the common source connection for the transistors.

#### **PINNING - SOT279A**

PIN	DESCRIPTION		
1	drain 1		
2	gate 1		
3	gate 2		
4	drain 2		
5	source		



## CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

WARNING

# Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

## QUICK REFERENCE DATA

RF performance at T<sub>h</sub> = 25 °C in a push-pull common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>
	(MHz)	(V)	(W)	(dB)	(%)
CW, class-B	175	28	30	>14	>55

# BLF245B

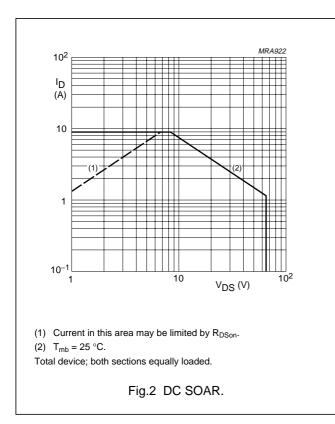
## LIMITING VALUES

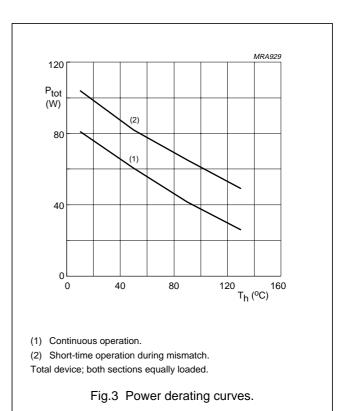
In accordance with the Absolute Maximum System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT		
Per transis	Per transistor section unless otherwise specified						
V <sub>DS</sub>	drain-source voltage		_	65	V		
±V <sub>GS</sub>	gate-source voltage		_	20	V		
ID	DC drain current		_	4.5	А		
P <sub>tot</sub>	total power dissipation	$T_{mb} \le 25 \text{ °C}$ ; total device; both sections equally loaded	-	75	W		
T <sub>stg</sub>	storage temperature		-65	+150	°C		
Tj	junction temperature		-	200	°C		

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	total device; both sections equally loaded	2.3	K/W
R <sub>th mb-h</sub>	thermal resistance from mounting base to heatsink	total device; both sections equally loaded	0.3	K/W





## BLF245B

## CHARACTERISTICS

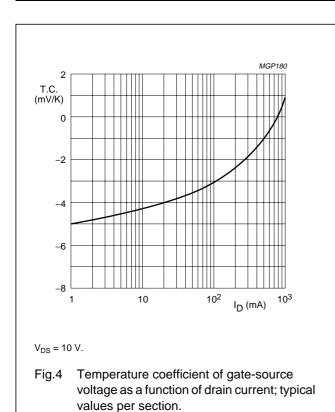
 $T_j$  = 25 °C unless otherwise specified.

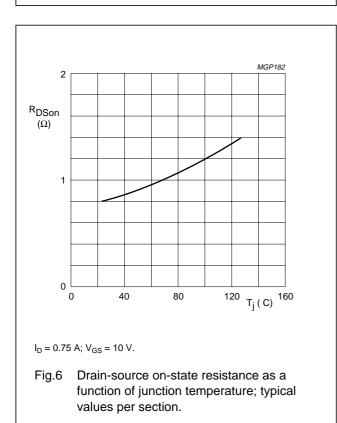
SYMBOL	PARAMETER	PARAMETER CONDITIONS		TYP.	MAX.	UNIT		
Per transisto	Per transistor section							
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_{D} = 5 \text{ mA}; V_{GS} = 0$	65	_	-	V		
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V	-	_	1	mA		
I <sub>GSS</sub>	gate-source leakage current	$\pm V_{GS} = 20 \text{ V}; \text{ V}_{DS} = 0$	-	_	1	μΑ		
V <sub>GSth</sub>	gate-source threshold voltage	I <sub>D</sub> = 5 mA; V <sub>DS</sub> = 10 V	2	_	4.5	V		
<b>g</b> fs	forward transconductance	I <sub>D</sub> = 0.75 A; V <sub>DS</sub> = 10 V	600	850	-	mS		
R <sub>DSon</sub>	drain-source on-state resistance	I <sub>D</sub> = 0.75 A; V <sub>GS</sub> = 10 V	-	0.8	1.5	Ω		
I <sub>DSX</sub>	on-state drain current	V <sub>GS</sub> = 10 V; V <sub>DS</sub> = 10 V	-	5	-	А		
C <sub>is</sub>	input capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	_	60	_	pF		
C <sub>os</sub>	output capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	40	-	pF		
C <sub>rs</sub>	feedback capacitance	V <sub>GS</sub> = 0; V <sub>DS</sub> = 28 V; f = 1 MHz	-	4.5	-	pF		

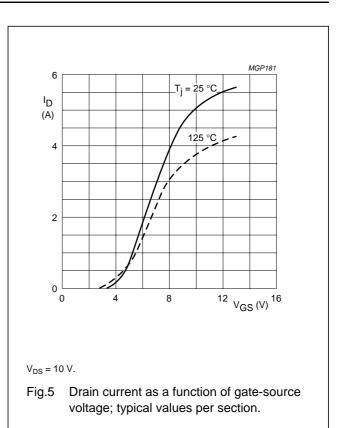
## V<sub>GS</sub> group indicator

GROUP	LIMITS (V)		GROUP	LIMITS (V)		
	MIN.	MAX.		MIN.	MAX.	
A	2.0	2.1	0	3.3	3.4	
В	2.1	2.2	Р	3.4	3.5	
С	2.2	2.3	Q	3.5	3.6	
D	2.3	2.4	R	3.6	3.7	
E	2.4	2.5	S	3.7	3.8	
F	2.5	2.6	Т	3.8	3.9	
G	2.6	2.7	U	3.9	4.0	
Н	2.7	2.8	V	4.0	4.1	
J	2.8	2.9	W	4.1	4.2	
К	2.9	3.0	Х	4.2	4.3	
L	3.0	3.1	Y	4.3	4.4	
М	3.1	3.2	Z	4.4	4.5	
N	3.2	3.3				

## BLF245B







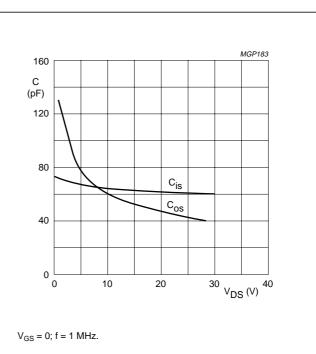
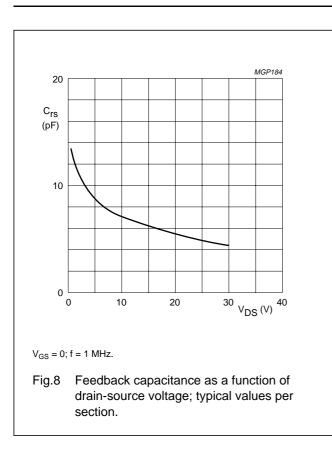


Fig.7 Input and output capacitance as functions of drain-source voltage; typical values per section.



## APPLICATION INFORMATION FOR CLASS-B OPERATION

 $T_h = 25 \text{ °C}$ ;  $R_{th mb-h} = 0.3 \text{ K/W}$ ; unless otherwise specified. RF performance in a push-pull, common source, class-B test circuit.

MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (mA)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)
CW, class-B	175	28	2 × 25	30	>14	>55
					typ. 18	typ. 65

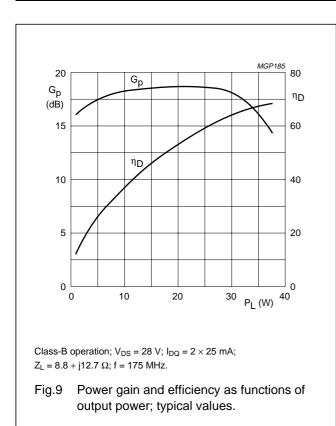
## Ruggedness in class-B operation

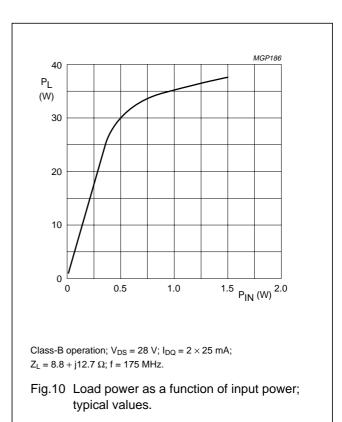
The BLF245B is capable of withstanding a load mismatch corresponding to VSWR = 50 through all phases, under the following conditions:

 $V_{\text{DS}}$  = 28 V, f = 175 MHz at rated output power.

## BLF245B

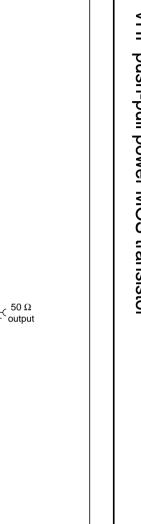
# BLF245B





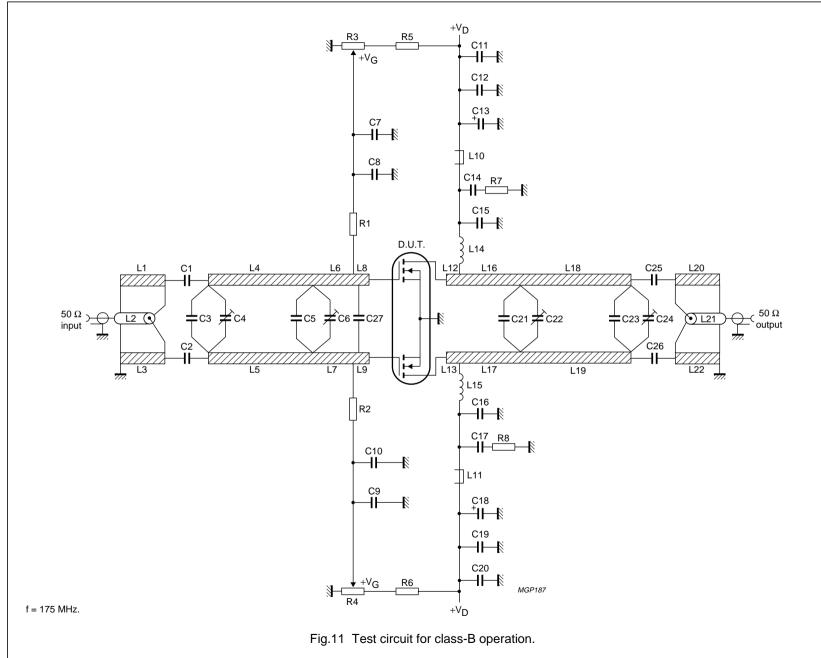


Product specification



# VHF push-pull power MOS transistor

BLF245B



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2003 Aug 04

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## BLF245B

## List of components (see Fig.11)

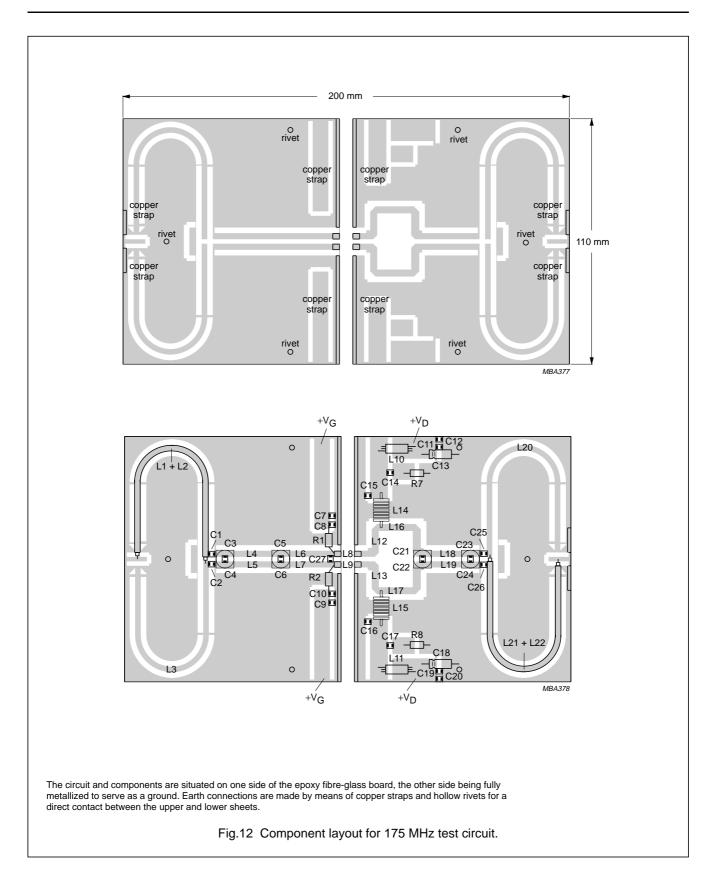
COMPONENT DESCRIPTION		VALUE	DIMENSIONS	CATALOGUE NO.
C1,C2	multilayer ceramic chip capacitor; note 1	270 pF		
C3	multilayer ceramic chip capacitor; note 1	24 pF		
C4	film dielectric trimmer	4 to 60 pF		2222 809 08002
C5, C25, C26	multilayer ceramic chip capacitor; note 1	91 pF		
C6, C22, C24	film dielectric trimmer	5 to 60 pF		2222 809 08003
C7, C9, C12, C14, C17, C19	multilayer ceramic chip capacitor	100 nF		2222 852 47104
C8, C10	multilayer ceramic chip capacitor; note 1	680 pF		
C11, C20	multilayer ceramic chip capacitor	10 nF		2222 852 47103
C13, C18	electrolytic capacitor	10 μF, 63 V		
C15, C16	multilayer ceramic chip capacitor; note 1	100 pF		
C21, C27	multilayer ceramic chip capacitor; note 1	75 pF		
C23	multilayer ceramic chip capacitor; note 1	36 pF		
L1, L3, L20, L22	stripline; note 2	55 Ω	length 111 mm width 2.5 mm	
L2, L21	semi-rigid cable	50 Ω	length 111 mm ext. dia. 2.2 mm	
L4, L5	stripline; note 2	49.5 Ω	length 28 mm width 3 mm	
L6, L7	_7 stripline; note 2		length 22.5 mm width 3 mm	
L8, L9	stripline; note 2	49.5 Ω	length 4.5 mm width 3 mm	
L10, L11	grade 3B Ferroxcube RF choke			4312 020 36642
L12, L13	stripline; note 2	49.5 Ω	length 21 mm width 3 mm	
L14, L15	L14, L15 4 turns enamelled 1 mm copper wire		length 9 mm int. dia. 6 mm leads 2 × 5 mm	
L16, L17	stripline; note 2	49.5 Ω	length 30 mm width 3 mm	
L18, L19	stripline; note 2	49.5 Ω	length 26 mm width 3 mm	
R1, R2	0.4 W metal film resistor	10 Ω		
R3, R4	10 turns potentiometer	50 Ω		
R5, R6	0.4 W metal film resistor	205 kΩ		
R7, R8	0.4 W metal film resistor	10 Ω		

## Notes

1. American Technical Ceramics (ATC) capacitor, type 100B or other capacitor of the same quality.

2. The striplines are on a double copper-clad printed circuit board, with epoxy glass dielectric ( $\epsilon_r = 4.5$ ), thickness  $1/_{16}$  inch. The other side of the board is fully metallized and used as a ground plane. The ground planes on each side of the board are connected together by means of copper straps and hollow rivets.

## BLF245B



# BLF245B

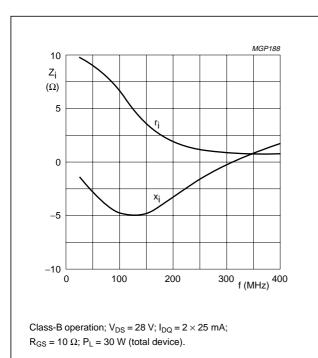
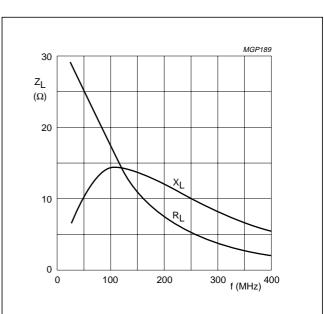
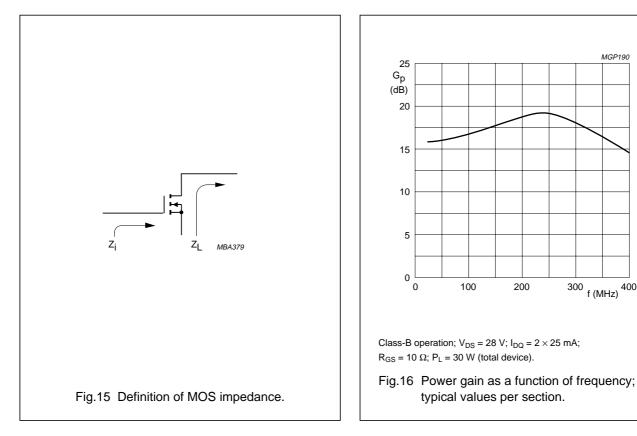


Fig.13 Input impedance as a function of frequency (series components); typical values per section.



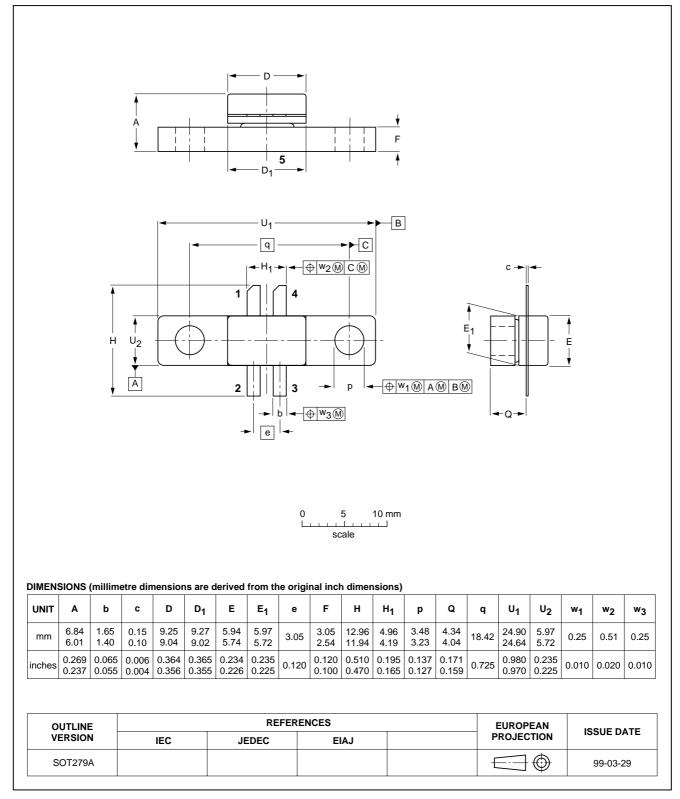
Class-B operation; V<sub>DS</sub> = 28 V; I<sub>DQ</sub> = 2 × 25 mA; R<sub>GS</sub> = 10  $\Omega$ ; P<sub>L</sub> = 30 W (total device).

Fig.14 Load impedance as a function of frequency (series components); typical values per section.



## PACKAGE OUTLINE





BLF245B

SOT279A

BLF245B

#### DATA SHEET STATUS

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)(3)</sup>	DEFINITION
1	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
11	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

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- 2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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